Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/711,817	LIN ET AL.	
Examiner	Art Unit	

Paul Nguyen-Ba

2176

	SEARCHED					
Class	Subclass	Date	Examiner			
715	536 542 530	10/26/2006	PNB			
			1			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
USPAT US-PGPUB EPO JPO DERWENT IBM_TDB	10/26/2006	PNB		
ACM DIGITAL LIBRARY	10/26/2006	PNB		